

<b>Notice of References Cited</b>	Application/Control No. 10/565,810		Applicant(s)/Patent Under Reexamination NEFTEL ET AL.	
	Examiner LARRY R. WILSON		Art Unit 3767	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,684,829 A	07-1954	MC FARLAND JR ROLLAND	251/331
*	B	US-4,530,647 A	07-1985	Uno, Fumio	417/477.3
*	C	US-4,586,920 A	05-1986	Peabody, Alan M.	604/29
*	D	US-4,758,228 A	07-1988	Williams, David R.	604/153
*	E	US-4,828,545 A	05-1989	Epstein et al.	604/66
*	F	US-4,952,372 A	08-1990	Huber, Bernhard	422/81
*	G	US-5,350,357 A	09-1994	Kamen et al.	604/29
*	H	US-5,437,629 A	08-1995	Goldrath, Milton H.	604/21
*	I	US-5,478,211 A	12-1995	Dominiak et al.	417/234
*	J	US-5,518,378 A	05-1996	Neftel et al.	417/477.2
*	K	US-5,683,233 A	11-1997	Moubayed et al.	417/474
*	L	US-5,840,069 A	11-1998	Robinson, Reginald D.	604/131
*	M	US-5,722,947	03-1998	Jeppsson et al.	604/29

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP 1195171 A2	04-2002	European Patent	SUZUKI et al.	A61M 01/28
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.